

Please replace the paragraph beginning on line 1 of page 4 with the following:

Fig. 6 is a schematic diagram of a double pumped bus cell system according to an embodiment of the invention.

Please replace the paragraph beginning on line 3 of page 4 with the following:

Fig. 7 is a schematic diagram of a computer system according to an embodiment of the invention.

Please replace the paragraph beginning on line 7 of page 4 with the following:

Referring to Fig. 3, an embodiment 100 of a double pumped bus cell in accordance with the invention may be set up to communicate either one or two sets of data. More specifically, in some embodiments of the invention, an EN signal that is received by the cell 100 may be asserted (driven high, for example) to enable the cell 100 to latch, store and retransmit bits of data from two different data sets in a time multiplexed fashion. In this manner, a data line 107 communicates a signal (called DATAIN) that indicates bits of data from a first data set and a second data set. The bits of the first data set are interleaved, or alternate, in time with the bits of the second data set.

Please replace the paragraph beginning on line 6 of page 6 with the following:

Fig. 4 depicts a more detailed schematic diagram of the cell 100 in accordance with some embodiments of the invention. As shown, the bit latch 102 may include a circuit 140 that is effectively a complementary metal oxide semiconductor (CMOS) inverter that is enabled when the CLK signal (that alternates between logic one and logic zero states) is in a logic one state to latch the bit that is indicated by the DATAIN signal. To accomplish this, the circuit 140 includes an n-channel metal-oxide-semiconductor field-effect-transistor (NMOSFET) 148 that has its source terminal coupled to ground and its drain terminal coupled to the source terminal of another NMOSFET 146. The drain terminal of the NMOSFET 146 is coupled to the drain terminal of a p-channel metal-oxide-semiconductor field-effect-transistor (PMOSFET) 144. The source terminal of the PMOSFET 144 is coupled to the drain terminal of another PMOSFET 142, and the drain terminal of the PMOSFET 142 is coupled to a positive voltage supply level (called  $V_{DD}$ ). The gate terminals of the PMOSFET 144 and the NMOSFET 146 respond to the logical state of the CLK signal to control when the circuit 140 is enabled. In this manner, the

gate terminal of the PMOSFET 144 is coupled to a clock input terminal 131 (that furnishes the CLK signal) via a chain 124 of three serially coupled inverters 240 that invert the CLK signal to receive an inverted version of the CLK signal. The gate terminal of the NMOSFET 146 is coupled to a chain 123 of serially coupled inverters 120 to the clock line 131 to receive an indication of the CLK signal. The gate terminals of the PMOSFET 142 and the NMOSFET 148 are coupled to the data input line 107.

Please replace the paragraph beginning on line 7 of page 8 with the following:

The cell 100 that is described above receives time-multiplexed bits of data from a single wire. However, in some embodiments of the invention, a cell 200 that is depicted in Fig. 5 may be used in place of the cell 100. The cell 200 has a similar design to the cell 100 except for the following features. Unlike the cell 100, the cell 200 has two data input lines 203 and 205 (instead of one) to receive bits of data from circuits that are associated with two different data sets. In this manner, the inverter 108 (see Fig. 3) of the cell 100 is replaced by two inverters 202 and 207 of the circuit 200. The input terminal of the inverter 202 receives a signal (called DATA1) that is indicative of bits of data from the first data set, and the input terminal of the inverter 207 receives a signal (called DATA2) that is indicative of bits of data from the second data set. The output terminal of the inverter 202 is coupled to the data input line of the bit latch 102, and the output terminal of the inverter 207 is coupled to the data input line of the bit latch 104.

Please replace the paragraph beginning on line 19 of page 8 with the following:

Referring to Fig. 6, in some embodiments of the invention, the cells 100 (the enabled cells 100a and the disabled cells 100b, as described below) and 200 may be used to form a double pumped bus chain 220 for purposes of communicating the bits of data from the first and second data sets across an integrated circuit, for example. In this manner, the cell 200 is the first in the chain 220 to arrange bits from the two different data sets in a time interleaved fashion. The cells 100 may be serially coupled together after the cell 200. As shown, to disable the flow of the bits of the data set that is associated with the DATA2 signal, every other cell 100 is disabled, as depicted in Fig. 6 by the enabled cells 100a and the disabled cells 100b. This alternative disabling of the cells 100 occurs because each cell 100 reverses the phasing of the data flow. For

example, each cell 100 receives the bits of a particular data set on positive clock edges and retransmits the bits of that data set on negative clock edges. The arrangement that is depicted in Fig. 6 is used to disable the flow of bits for the data set that is associated with the DATA2 signal. However, alternatively, to disable the bits for the data set that is associated with the DATA1 signal, the enable input terminals 113 of the cells 200 and 100b are asserted, and the enable input terminals 113 of the cells 100a are de-asserted.

Please replace the paragraph beginning on line 4 of page 9 with the following:

Referring to Fig. 7, as an example, the cell 200 (and/or the cell 100) may be used in a semiconductor circuit, such as a processor 252 (a microprocessor, such as a Pentium® microprocessor, as an example), to communicate bits of data between circuits 254, 256, 260 and 262 of the processor 252. In this manner, the cell 200 may communicate data over a wire 258 for two data sets. More specifically, the cell 200 may communicate data for a first data set between the circuit 254 that is located at one end of the wire 258 and the circuit 260 that is located at another end of the wire 268. The cell 200 may also communicate data for a second data set between the circuit 256 that is located at one end of the wire 258 and the circuit 262 that is located at the other end of the wire 268.